

BUD43D2

Bipolar NPN Transistor

High Speed, High Gain Bipolar NPN Transistor Integrating an Antisaturation Network and a Transient Voltage Suppression Capability

The BUD43D2 is a state-of-the-art bipolar transistor. Tight dynamic characteristics and lot to lot minimum spread make it ideally suitable for light ballast applications.

Main Features:

- Free Wheeling Diode Built In
- Flat DC Current Gain
- Fast Switching Times and Tight Distribution
- "6 Sigma" Process Providing Tight and Reproducible Parameter Spreads

Two Versions:

- BUD43D2-1: Case 369 for Insertion Mode
- BUD43D2: Case 369A for Surface Mount Mode

MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Collector-Emitter Sustaining Voltage	V_{CEO}	400	Vdc
Collector-Base Breakdown Voltage	V_{CBO}	700	Vdc
Collector-Emitter Breakdown Voltage	V_{CES}	700	Vdc
Emitter-Base Voltage	V_{EBO}	12	Vdc
Collector Current – Continuous – Peak (Note 1)	I_C I_{CM}	2.0 5.0	Adc
Base Current – Continuous – Peak (Note 1)	I_B I_{BM}	1.0 2.0	Adc

TYPICAL GAIN

Typical Gain @ $I_C = 100\text{ mA}$, $V_{CE} = 1\text{ V}$ @ $I_C = 0.3\text{ A}$, $V_{CE} = 1\text{ V}$	h_{FE}	55 32	–
---	----------	----------	---

THERMAL CHARACTERISTICS

Characteristic	Symbol	Value	Unit
Total Device Dissipation @ $T_C = 25^\circ\text{C}$ Derate above 25°C	P_D	25 0.2	W W/ $^\circ\text{C}$
Operating and Storage Temperature Range	T_J, T_{stg}	-65 to +150	$^\circ\text{C}$
Thermal Resistance – Junction-to-Case	$R_{\theta JC}$	5.0	$^\circ\text{C/W}$
Thermal Resistance – Junction-to-Ambient	$R_{\theta JA}$	71.4	$^\circ\text{C/W}$
Maximum Lead Temperature for Soldering Purposes: 1/8" from Case for 5 sec.	T_L	260	$^\circ\text{C}$

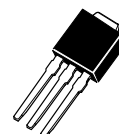
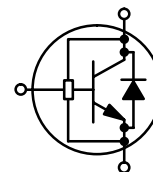
1. Pulse Test: Pulse Width = 5.0 ms, Duty Cycle = 10%



ON Semiconductor®

<http://onsemi.com>

**2 AMPERES
700 VOLTS
25 WATTS
POWER TRANSISTOR**

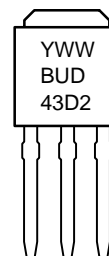


DPAK
CASE 369
STYLE 1



DPAK
CASE 369A
STYLE 1

MARKING DIAGRAMS



Y = Year
WW = Work Week
BUD43D2 = Device Code

ORDERING INFORMATION

Device	Package	Shipping
BUD43D2-1	DPAK	75 Units/Rail

BUD43D2

ELECTRICAL CHARACTERISTICS ($T_C = 25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
----------------	--------	-----	-----	-----	------

OFF CHARACTERISTICS

Collector–Emitter Sustaining Voltage ($I_C = 100\text{ mA}$, $L = 25\text{ mH}$)	$V_{CEO(sus)}$	400	470	–	Vdc
Collector–Base Breakdown Voltage ($I_{CBO} = 1\text{ mA}$)	@ $T_C = 25^\circ\text{C}$ V_{CBO}	700	920	–	Vdc
Emitter–Base Breakdown Voltage ($I_{EBO} = 1\text{ mA}$)	@ $T_C = 25^\circ\text{C}$ V_{EBO}	12	14.5	–	Vdc
Collector Cutoff Current ($V_{CE} = \text{Rated } V_{CEO}$, $I_B = 0$)	@ $T_C = 25^\circ\text{C}$ @ $T_C = 125^\circ\text{C}$ I_{CEO}	– –	– –	50 500	μA dc
Collector Cutoff Current ($V_{CE} = \text{Rated } V_{CES}$, $V_{EB} = 0$) ($V_{CE} = 500\text{ V}$, $V_{EB} = 0$)	@ $T_C = 25^\circ\text{C}$ @ $T_C = 125^\circ\text{C}$ @ $T_C = 125^\circ\text{C}$ I_{CES}	– – –	– – –	50 500 100	μA dc
Emitter–Cutoff Current ($V_{EB} = 10\text{ Vdc}$, $I_C = 0$)	@ $T_C = 25^\circ\text{C}$ I_{EBO}	–	–	100	μA dc

ON CHARACTERISTICS

Base–Emitter Saturation Voltage ($I_C = 0.4\text{ Adc}$, $I_B = 40\text{ mAdc}$) ($I_C = 1\text{ Adc}$, $I_B = 0.2\text{ Adc}$)	@ $T_C = 25^\circ\text{C}$ @ $T_C = 125^\circ\text{C}$	$V_{BE(sat)}$	– –	0.78 0.65	0.9 0.8	Vdc
	@ $T_C = 25^\circ\text{C}$ @ $T_C = 125^\circ\text{C}$		– –	0.85 0.76	1.0 0.9	
Collector–Emitter Saturation Voltage ($I_C = 0.4\text{ Adc}$, $I_B = 20\text{ mAdc}$) ($I_C = 0.4\text{ Adc}$, $I_B = 40\text{ mAdc}$) ($I_C = 1\text{ Adc}$, $I_B = 0.2\text{ Adc}$)	@ $T_C = 25^\circ\text{C}$ @ $T_C = 125^\circ\text{C}$	$V_{CE(sat)}$	– –	0.40 0.60	0.65 1.0	Vdc
	@ $T_C = 25^\circ\text{C}$ @ $T_C = 125^\circ\text{C}$		– –	0.20 0.20	0.4 0.5	
	@ $T_C = 25^\circ\text{C}$ @ $T_C = 125^\circ\text{C}$		– –	0.25 0.30	0.5 0.6	
DC Current Gain ($I_C = 0.4\text{ Adc}$, $V_{CE} = 1\text{ Vdc}$) ($I_C = 1\text{ Adc}$, $V_{CE} = 1\text{ Vdc}$) ($I_C = 2\text{ Adc}$, $V_{CE} = 5\text{ Vdc}$)	@ $T_C = 25^\circ\text{C}$ @ $T_C = 125^\circ\text{C}$	h_{FE}	20 18	32 26	– –	–
	@ $T_C = 25^\circ\text{C}$ @ $T_C = 125^\circ\text{C}$		10 7.0	15 9.5	– –	
	@ $T_C = 25^\circ\text{C}$		8.0	13	–	
	@ $T_C = 25^\circ\text{C}$					

DIODE CHARACTERISTICS

Forward Diode Voltage ($I_{EC} = 0.2\text{ Adc}$) ($I_{EC} = 0.2\text{ Adc}$) ($I_{EC} = 0.4\text{ Adc}$) ($I_{EC} = 1\text{ Adc}$)	@ $T_C = 25^\circ\text{C}$	V_{EC}	–	0.8	1.0	Vdc
	@ $T_C = 125^\circ\text{C}$		–	0.6	–	
	@ $T_C = 25^\circ\text{C}$		–	0.9	1.2	
	@ $T_C = 25^\circ\text{C}$		–	1.1	1.5	
Forward Recovery Time (see Figure 22) ($I_F = 0.2\text{ Adc}$, $di/dt = 10\text{ A}/\mu\text{s}$) ($I_F = 0.4\text{ Adc}$, $di/dt = 10\text{ A}/\mu\text{s}$) ($I_F = 1\text{ Adc}$, $di/dt = 10\text{ A}/\mu\text{s}$)	@ $T_C = 25^\circ\text{C}$	T_{fr}	–	415	–	ns
	@ $T_C = 25^\circ\text{C}$		–	390	–	
	@ $T_C = 25^\circ\text{C}$		–	340	–	

BUD43D2

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
----------------	--------	-----	-----	-----	------

DYNAMIC SATURATION VOLTAGE

Dynamic Saturation Voltage	I _C = 400 mA I _{B1} = 40 mA V _{CC} = 300 Vdc	@ 1 μs	@ T _C = 25°C @ T _C = 125°C	V _{CE(dsat)}	–	3.3	–	V
		@ 3 μs	@ T _C = 25°C @ T _C = 125°C		–	6.8	–	
	I _C = 1 A I _{B1} = 200 mA V _{CC} = 300 Vdc	@ 1 μs	@ T _C = 25°C @ T _C = 125°C		–	0.5	–	
		@ 3 μs	@ T _C = 25°C @ T _C = 125°C		–	1.3	–	
		@ 1 μs	@ T _C = 25°C @ T _C = 125°C		–	4.4	–	
		@ 3 μs	@ T _C = 25°C @ T _C = 125°C		–	12.8	–	

DYNAMIC CHARACTERISTICS

Current Gain Bandwidth (I _C = 0.5 Adc, V _{CE} = 10 Vdc, f = 1 MHz)	f _T	–	13	–	MHz
Output Capacitance (V _{CB} = 10 Vdc, I _E = 0, f = 1 MHz)	C _{ob}	–	50	75	pF
Input Capacitance (V _{EB} = 8 Vdc, f = 1 MHz)	C _{ib}	–	250	500	pF

SWITCHING CHARACTERISTICS: Resistive Load (V_{clamp} = 300 V, V_{CC} = 15 V, L = 200 μH)

Turn-on Time	I _C = 1 Adc, I _{B1} = 0.2 Adc I _{B2} = 0.5 Adc V _{CC} = 300 Vdc	@ T _C = 25°C @ T _C = 125°C	t _{on}	–	200	250	ns
Turn-off Time		@ T _C = 25°C @ T _C = 125°C	t _{off}	–	1.5	1.75	μs
Turn-on Time	I _C = 0.5 Adc, I _{B1} = 50 mAdc I _{B2} = 250 mAdc V _{CC} = 300 Vdc	@ T _C = 25°C @ T _C = 125°C	t _{on}	–	225	300	ns
Turn-off Time		@ T _C = 25°C @ T _C = 125°C	t _{off}	800	–	1100	ns

SWITCHING CHARACTERISTICS: Inductive Load

Fall Time	I _C = 0.4 Adc I _{B1} = 40 mAdc I _{B2} = 0.2 Adc	@ T _C = 25°C @ T _C = 125°C	t _f	–	90	150	ns
Storage Time		@ T _C = 25°C @ T _C = 125°C	t _s	–	0.55	0.75	μs
Crossover Time		@ T _C = 25°C @ T _C = 125°C	t _c	–	85	150	ns
Fall Time	I _C = 1.0 Adc I _{B1} = 0.2 Adc I _{B2} = 0.5 Adc	@ T _C = 25°C @ T _C = 125°C	t _f	–	100	150	ns
Storage Time		@ T _C = 25°C @ T _C = 125°C	t _s	–	1.05	1.5	μs
Crossover Time		@ T _C = 25°C @ T _C = 125°C	t _c	–	100	175	ns
Fall Time	I _C = 0.8 Adc I _{B1} = 160 mAdc I _{B2} = 160 mAdc	@ T _C = 25°C @ T _C = 125°C	t _f	–	110	150	ns
Storage Time		@ T _C = 25°C @ T _C = 125°C	t _s	2.5	–	2.8	μs
Crossover Time		@ T _C = 25°C @ T _C = 125°C	t _c	–	150	250	ns
Fall Time	I _C = 0.4 Adc I _{B1} = 40 mAdc I _{B2} = 40 mAdc	@ T _C = 25°C @ T _C = 125°C	t _f	–	150	225	ns
Storage Time		@ T _C = 25°C @ T _C = 125°C	t _s	1.7	–	2.0	μs
Crossover Time		@ T _C = 25°C @ T _C = 125°C	t _c	–	125	250	ns

BUD43D2

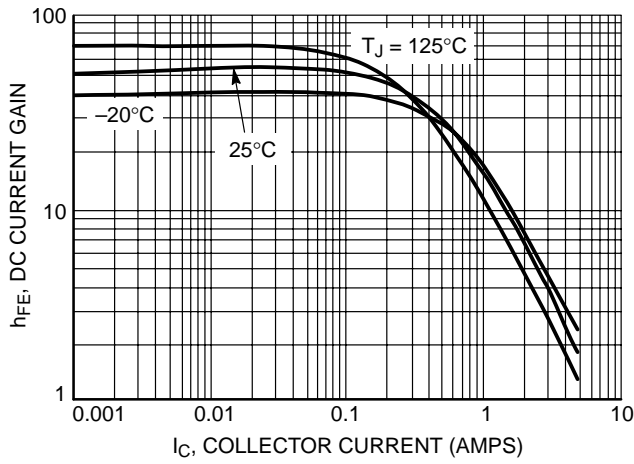


Figure 1. DC Current Gain @ $V_{CE} = 1\text{ V}$

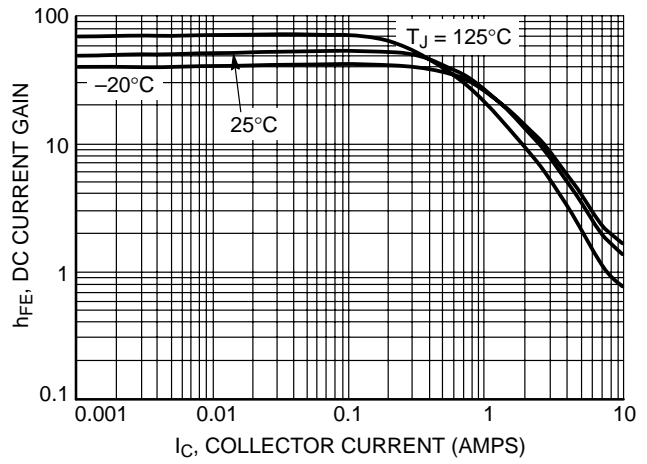


Figure 2. DC Current Gain @ $V_{CE} = 5\text{ V}$

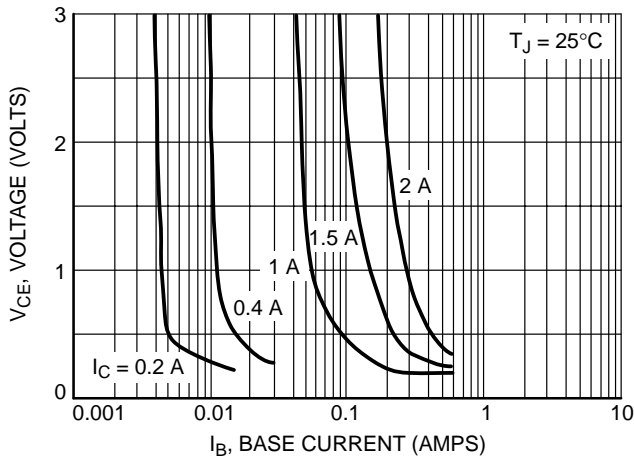


Figure 3. Collector Saturation Region

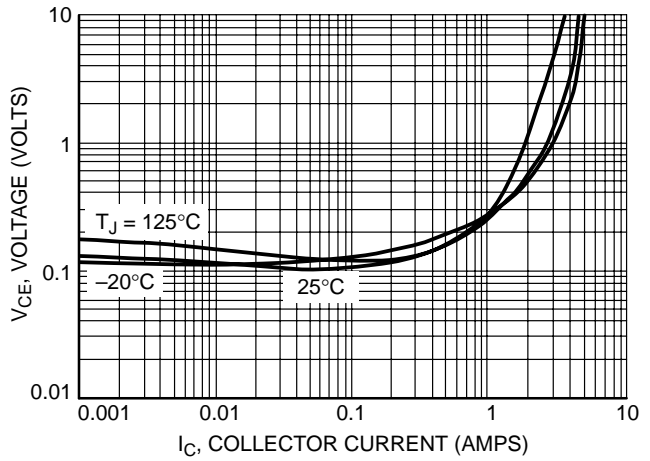


Figure 4. Collector-Emitter Saturation Voltage
 $I_C/I_B = 5$

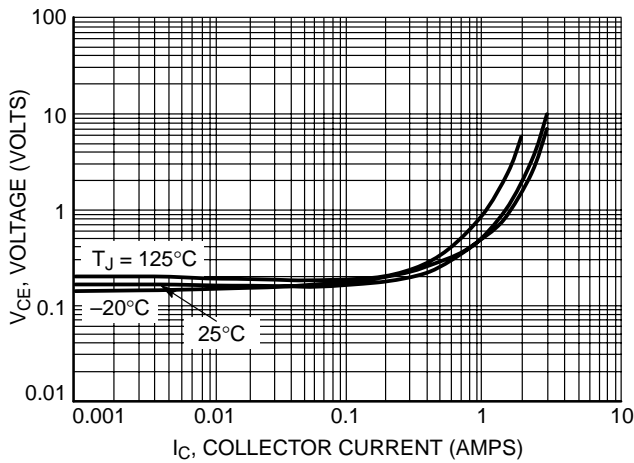


Figure 5. Collector-Emitter Saturation Voltage
 $I_C/I_B = 10$

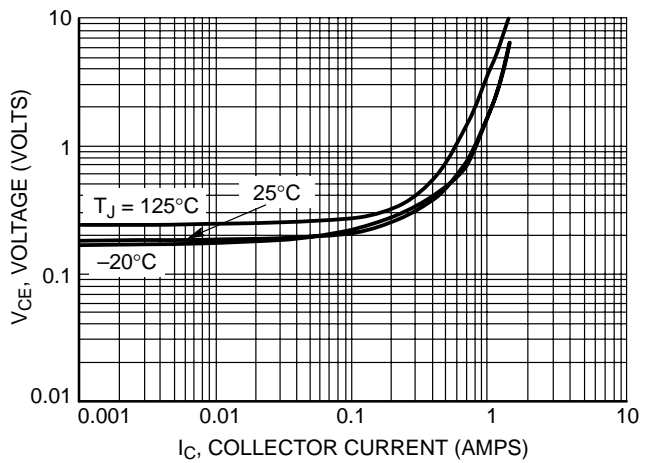


Figure 6. Collector-Emitter Saturation Voltage
 $I_C/I_B = 20$

BUD43D2

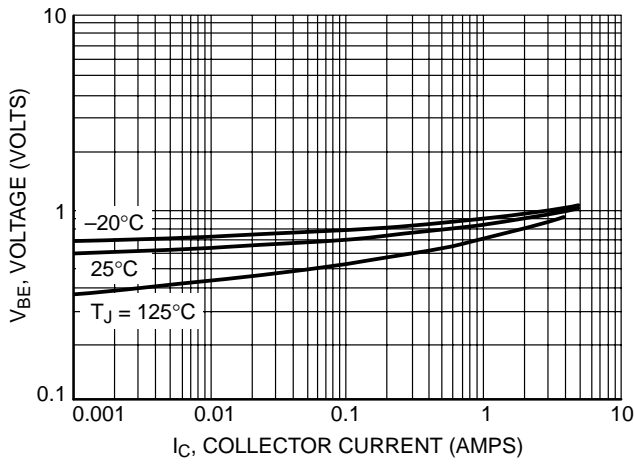


Figure 7. Base-Emitter Saturation Region
 $I_C/I_B = 5$

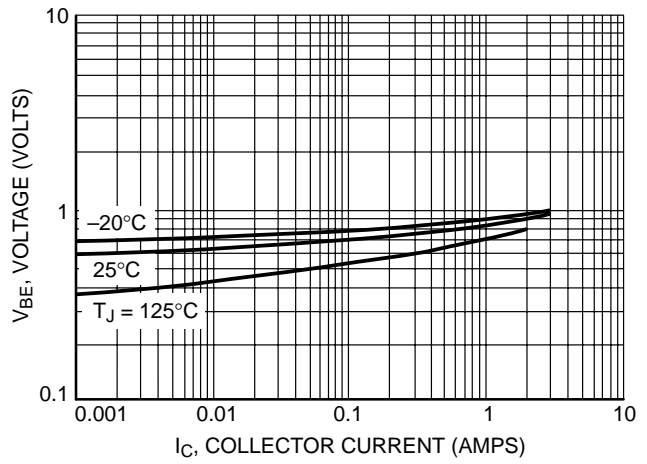


Figure 8. Base-Emitter Saturation Region
 $I_C/I_B = 10$

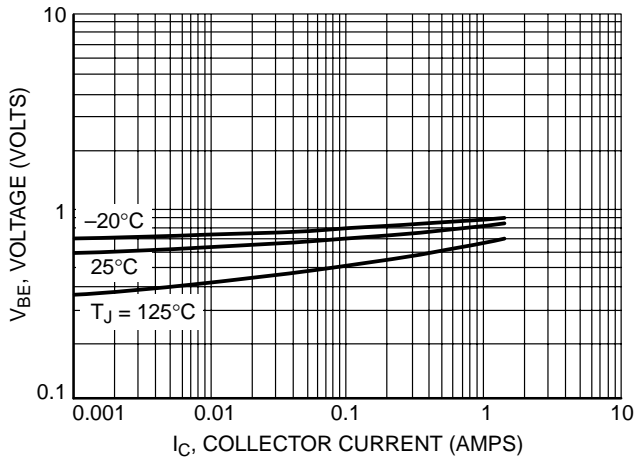


Figure 9. Base-Emitter Saturation Region
 $I_C/I_B = 20$

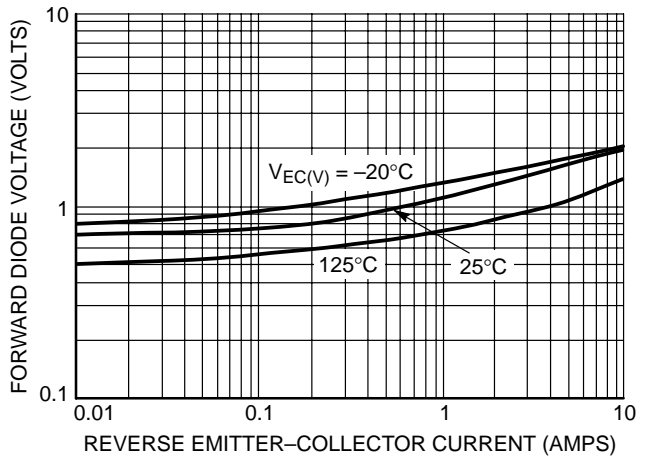


Figure 10. Forward Diode Voltage

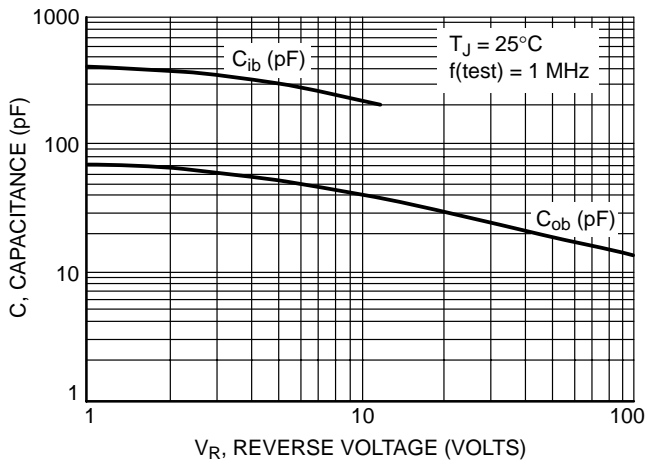


Figure 11. Capacitance

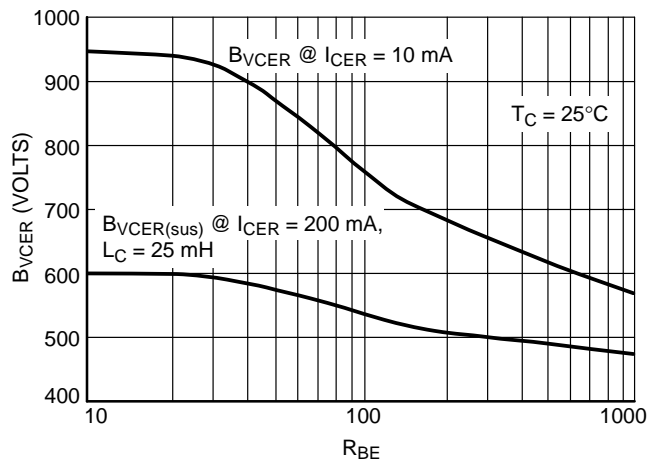


Figure 12. $B_{VCEr} = f(R_{BE})$

BUD43D2

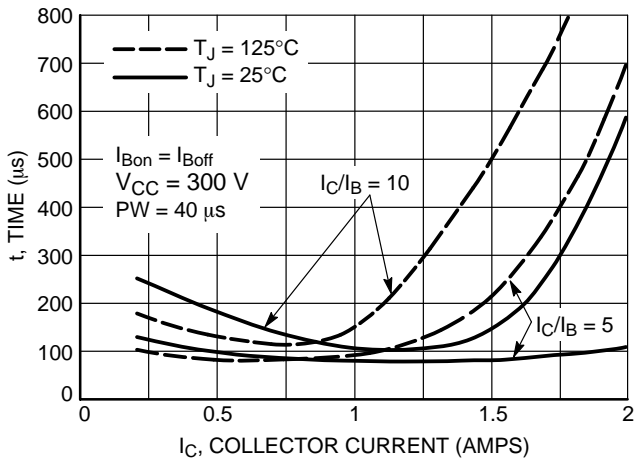


Figure 13. Resistive Switching, t_{on}

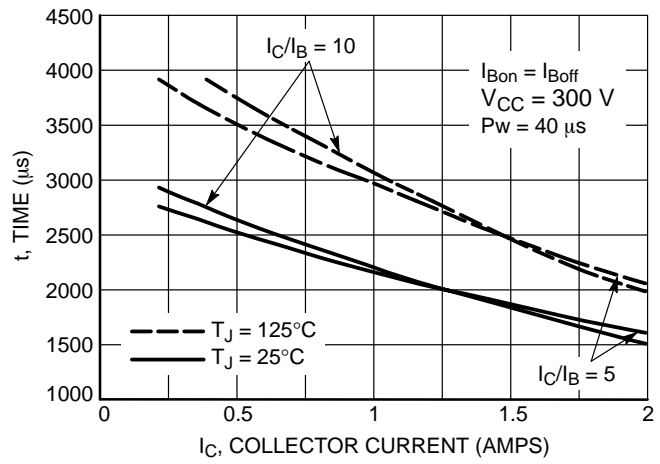


Figure 14. Resistive Switching, t_{off}

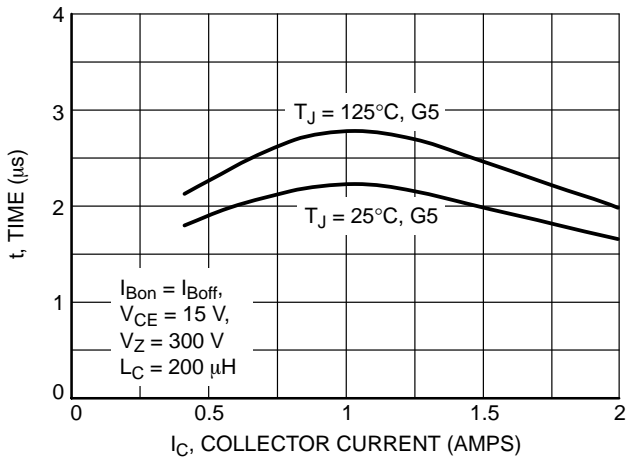


Figure 15. Inductive Storage Time, t_{si} @ $G = 5$

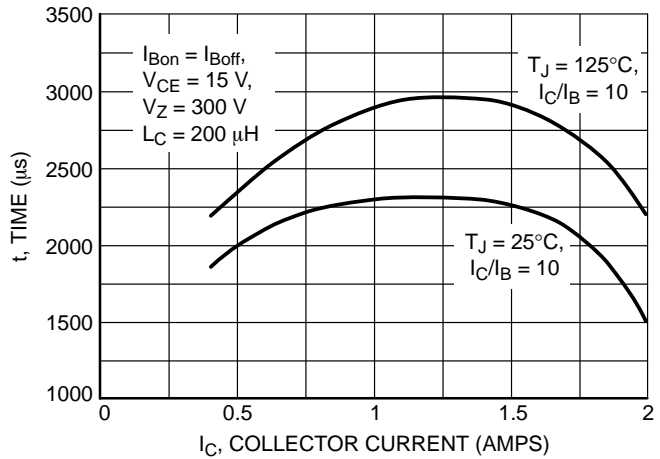


Figure 16. Inductive Storage Time, t_{si} @ $I_C/I_B = 10$

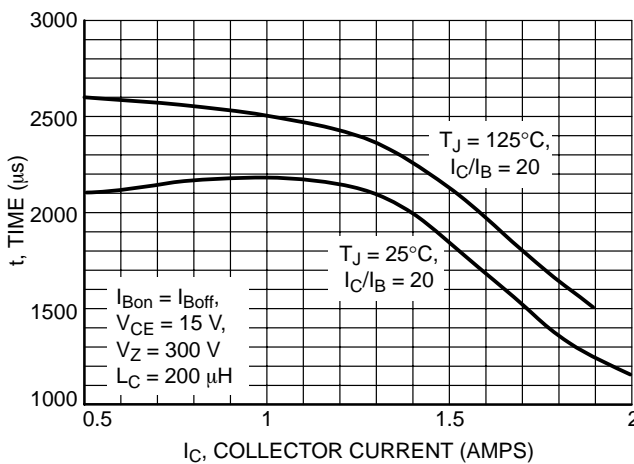


Figure 17. Inductive Storage Time, t_{si} @ $I_C/I_B = 20$

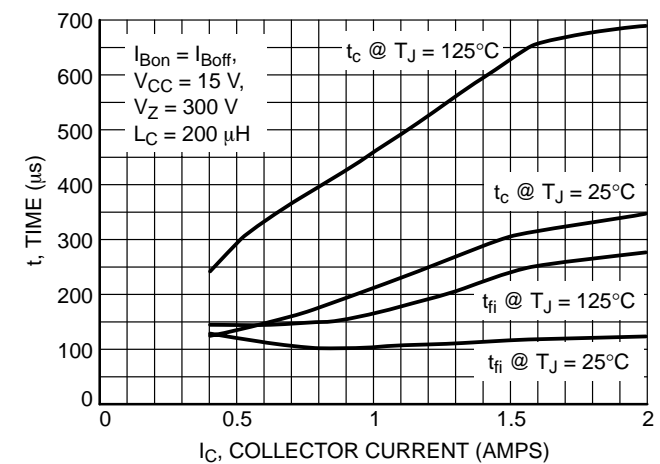


Figure 18. Inductive Fall and Cross Over Time, t_{fi} and t_c @ $h_{FE} = 5$

BUD43D2

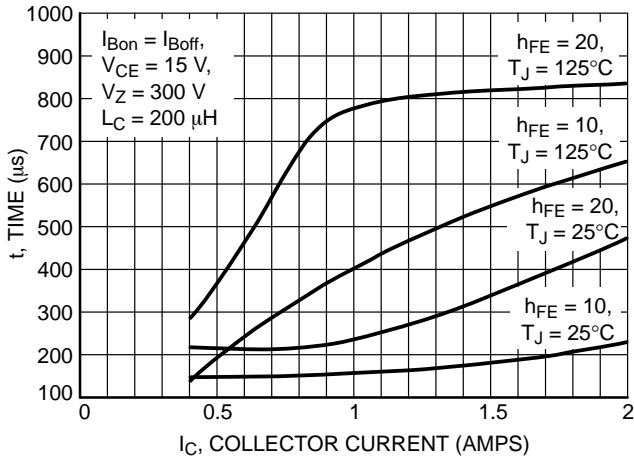


Figure 19. Inductive Fall Time, t_{fi} @ $h_{FE} = 10$ and 20

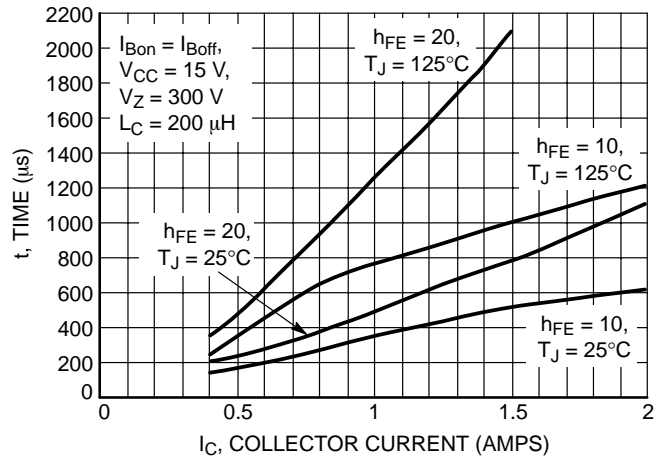


Figure 20. Inductive Cross Over Time, t_c @ $h_{FE} = 10$

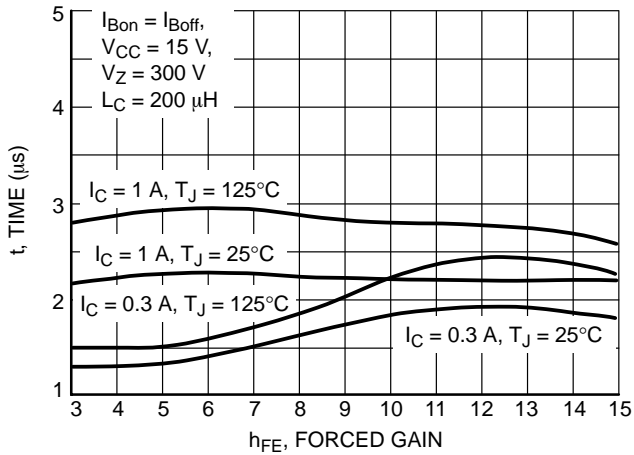


Figure 21. Inductive Storage Time, t_{si}

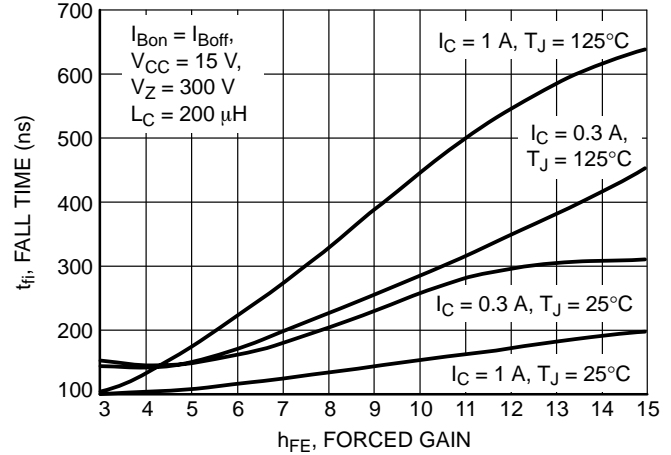


Figure 22. Inductive Fall Time, t_f

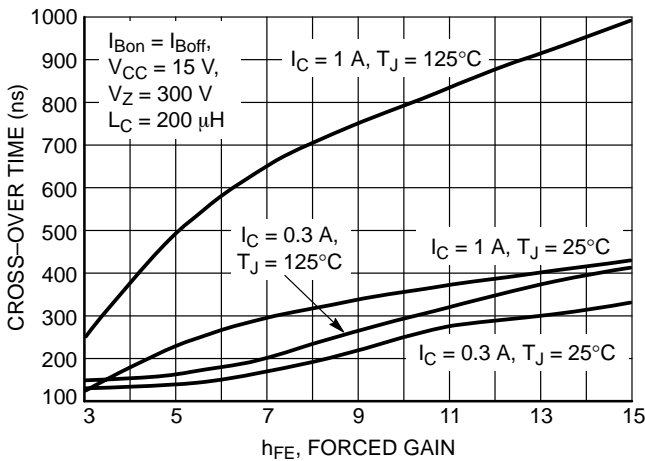


Figure 23. Inductive Cross Over Time, t_c

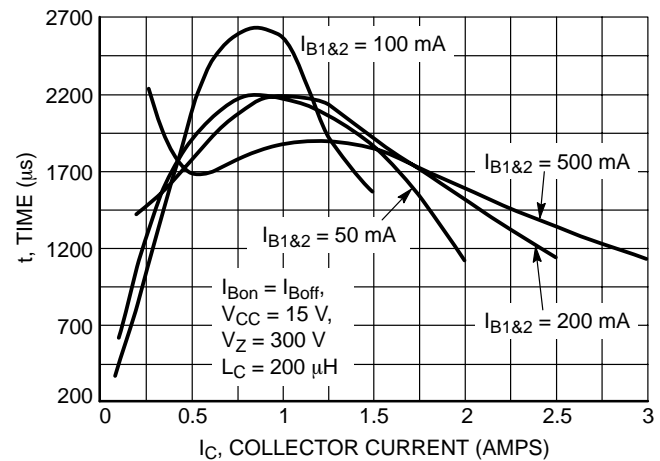


Figure 24. Inductive Storage Time, t_{si}

BUD43D2

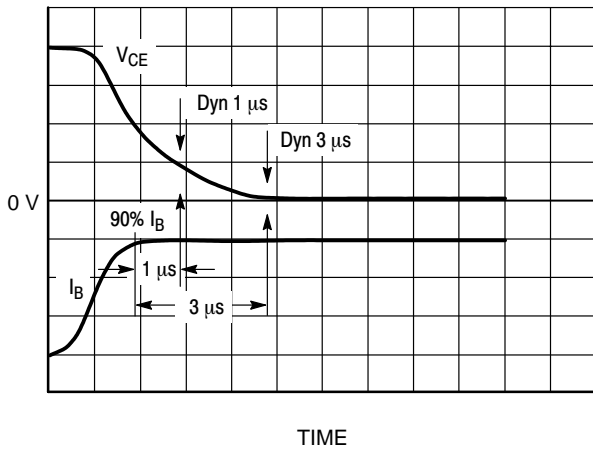


Figure 25. Dynamic Saturation Voltage Measurements

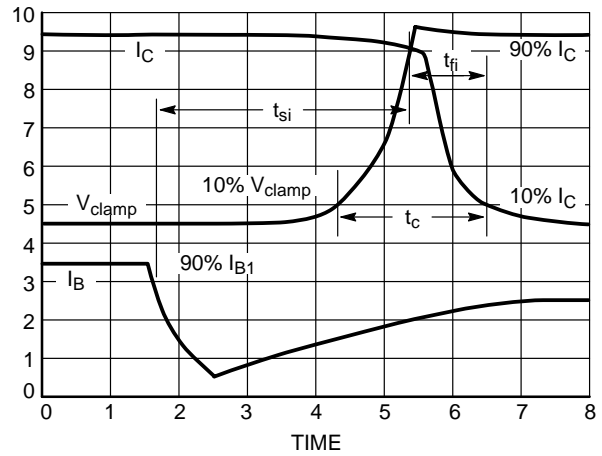
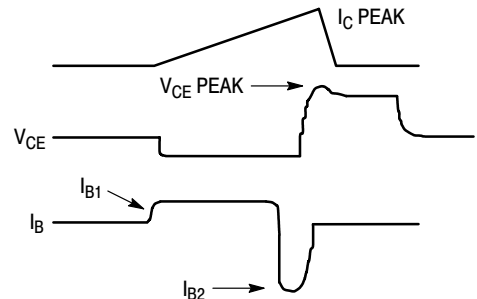
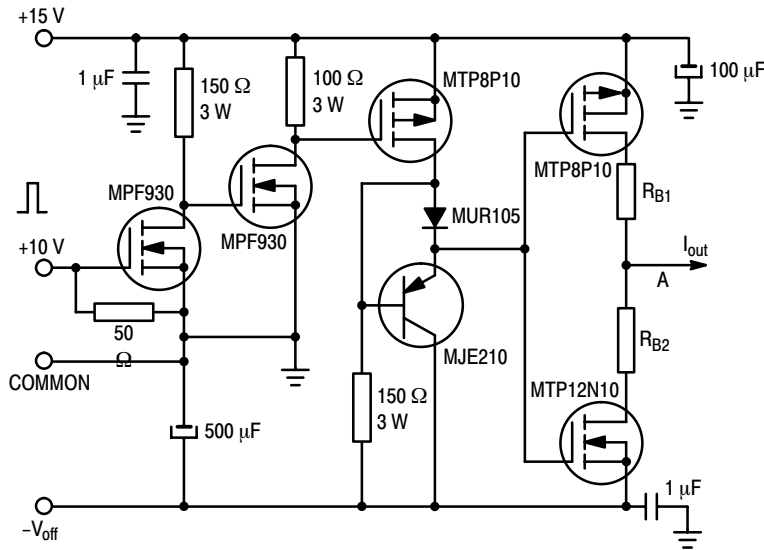


Figure 26. Inductive Switching Measurements

Table 1. Inductive Load Switching Drive Circuit



$V_{(BR)CEO(sus)}$	Inductive Switching	RBSOA
$L = 10 \text{ mH}$	$L = 200 \mu\text{H}$	$L = 500 \mu\text{H}$
$R_{B2} = \infty$	$R_{B2} = 0$	$R_{B2} = 0$
$V_{CC} = 20 \text{ Volts}$	$V_{CC} = 15 \text{ Volts}$	$V_{CC} = 15 \text{ Volts}$
$I_{C(pk)} = 100 \text{ mA}$	R_{B1} selected for desired I_{B1}	R_{B1} selected for desired I_{B1}

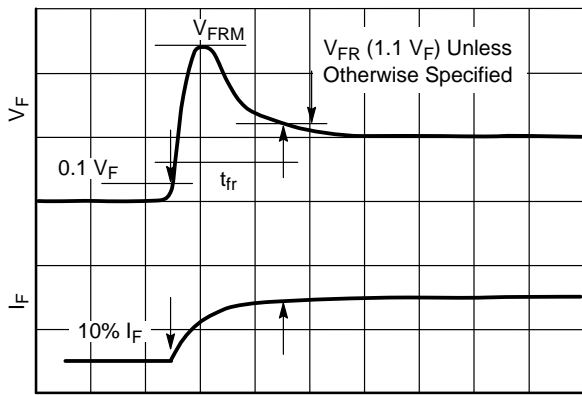


Figure 27. t_{fr} Measurement

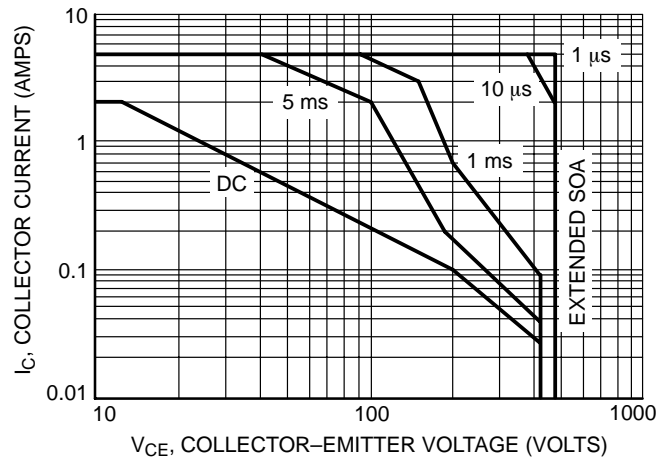


Figure 28. Forward Bias Safe Operating Area, Maximum Rating

BUD43D2

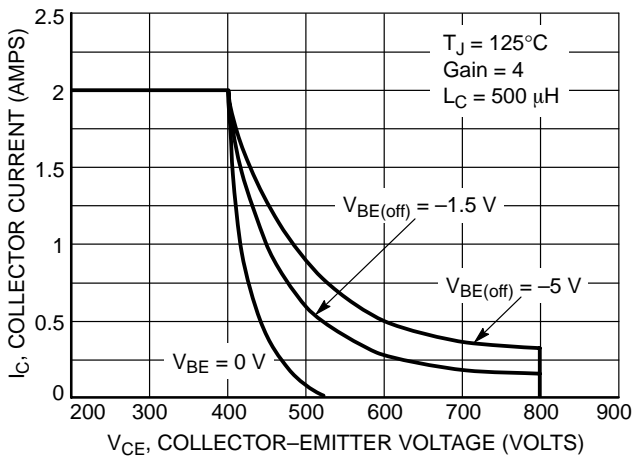


Figure 29. Reverse Bias Safe Operating Area, Maximum Rating

There are two limitations on the power handling ability of a transistor: average junction temperature and second breakdown. Safe operating area curves indicate I_C - V_{CE} limits of the transistor that must be observed for reliable operation; i.e., the transistor must not be subjected to greater dissipation than the curves indicate. The data of Figure 28 is based on $T_C = 25^\circ\text{C}$; $T_{J(pk)}$ is variable depending on power level. Second breakdown pulse limits are valid for duty cycles to 10% but must be derated when $T_C > 25^\circ\text{C}$. Second Breakdown limitations do not derate the same as thermal limitations. Allowable current at the voltages shown on

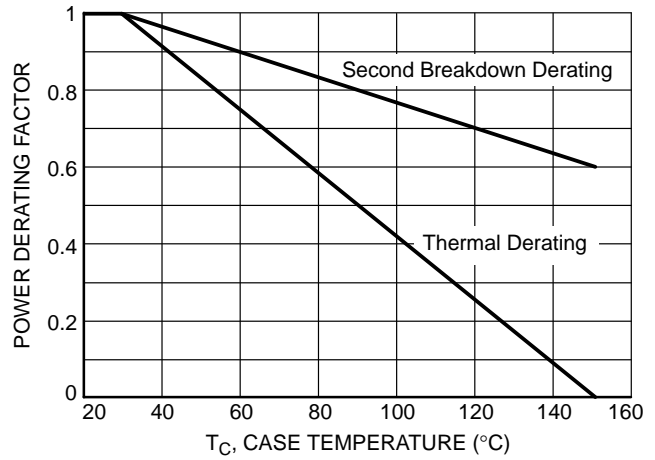


Figure 30. Power Derating

Figure 28 may be found at any case temperature by using the appropriate curve on Figure 30.

$T_{J(pk)}$ may be calculated from the data in Figure 31. At any case temperatures, thermal limitations will reduce the power that can be handled to values less than the limitations imposed by second breakdown. For inductive loads, high voltage and current must be sustained simultaneously during turn-off with the base to emitter junction reverse biased. The safe level is specified as reverse biased safe operating area (Figure 29). This rating is verified under clamped conditions so that the device is never subjected to an avalanche mode.

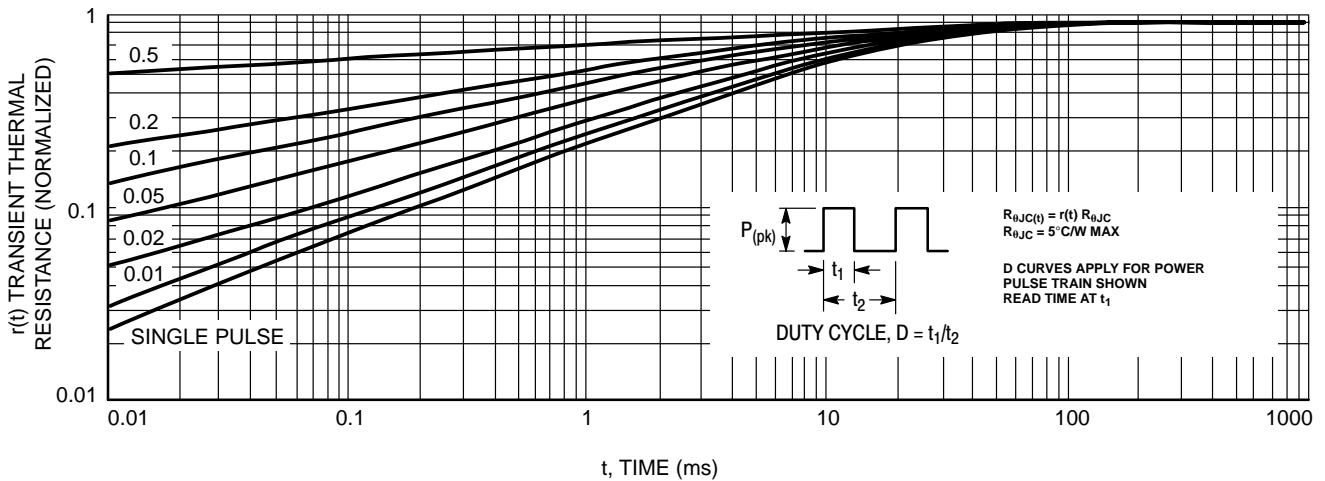
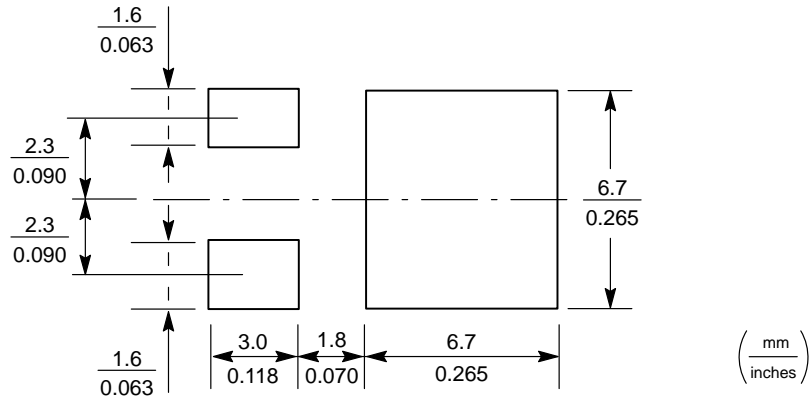


Figure 31. Thermal Response

Minimum Pad Sizes Recommended for Surface Mounted Applications



TYPICAL SOLDER HEATING PROFILE

For any given circuit board, there will be a group of control settings that will give the desired heat pattern. The operator must set temperatures for several heating zones, and a figure for belt speed. Taken together, these control settings make up a heating “profile” for that particular circuit board. On machines controlled by a computer, the computer remembers these profiles from one operating session to the next. Figure 32 shows a typical heating profile for use when soldering a surface mount device to a printed circuit board. This profile will vary among soldering systems but it is a good starting point. Factors that can affect the profile include the type of soldering system in use, density and types of components on the board, type of solder used, and the type of board or substrate material being used. This profile shows temperature versus time.

The line on the graph shows the actual temperature that might be experienced on the surface of a test board at or near a central solder joint. The two profiles are based on a high density and a low density board. The Vitronics SMD310 convection/infrared reflow soldering system was used to generate this profile. The type of solder used was 62/36/2 Tin Lead Silver with a melting point between 177–189°C. When this type of furnace is used for solder reflow work, the circuit boards and solder joints tend to heat first. The components on the board are then heated by conduction. The circuit board, because it has a large surface area, absorbs the thermal energy more efficiently, then distributes this energy to the components. Because of this effect, the main body of a component may be up to 30 degrees cooler than the adjacent solder joints.

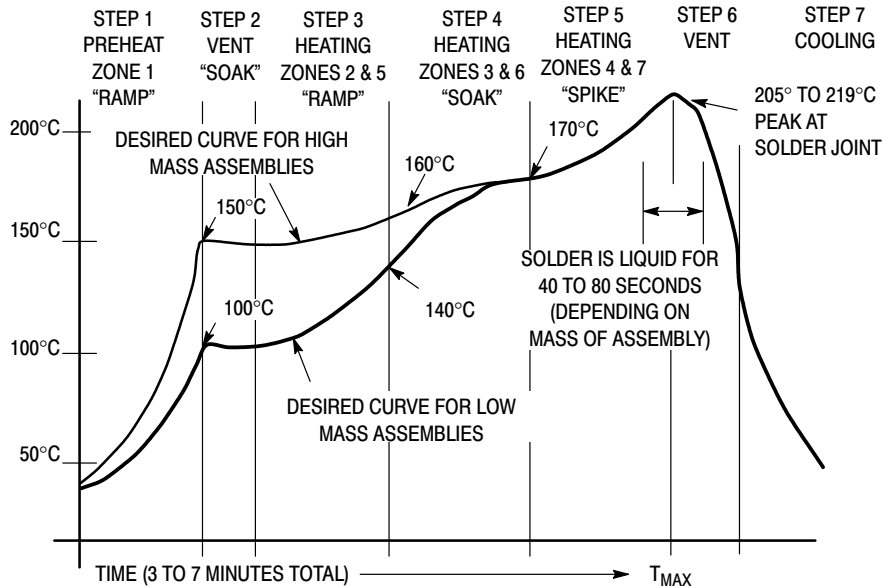
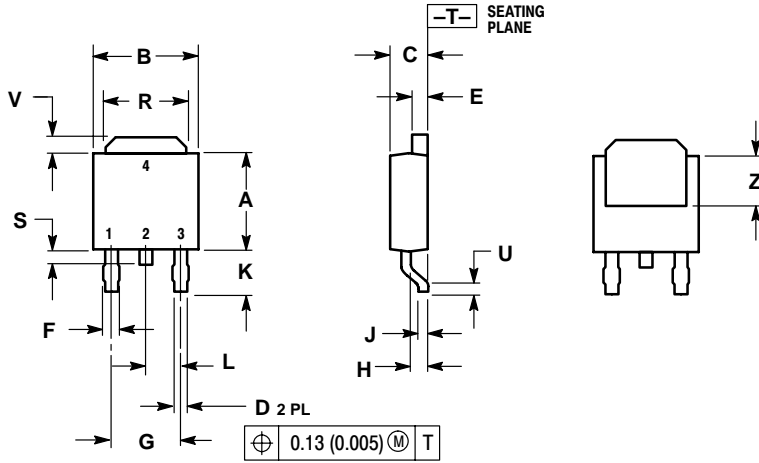


Figure 32. Typical Solder Heating Profile

BUD43D2

PACKAGE DIMENSIONS

DPAK
CASE 369A-13
ISSUE AB



NOTES:

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: INCH.

DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	0.235	0.250	5.97	6.35
B	0.250	0.265	6.35	6.73
C	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
E	0.033	0.040	0.84	1.01
F	0.037	0.047	0.94	1.19
G	0.180 BSC		4.58 BSC	
H	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
K	0.102	0.114	2.60	2.89
L	0.090 BSC		2.29 BSC	
R	0.175	0.215	4.45	5.46
S	0.020	0.050	0.51	1.27
U	0.020	---	0.51	---
V	0.030	0.050	0.77	1.27
Z	0.138	---	3.51	---

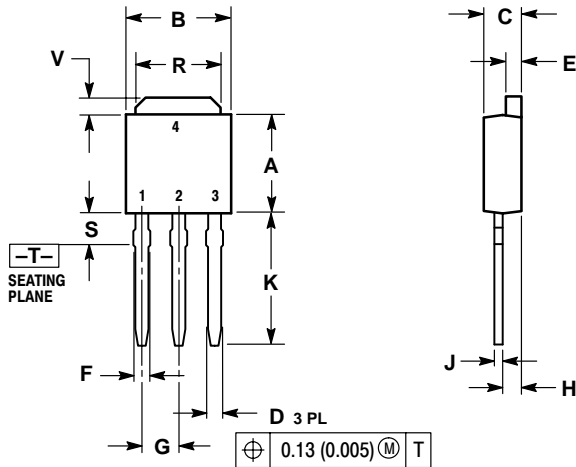
STYLE 1:

- PIN 1. BASE
- COLLECTOR
- EMITTER
- COLLECTOR

BUD43D2

PACKAGE DIMENSIONS


DPAK STRAIGHT LEADS CASE 369-07 ISSUE M



- NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: INCH.

DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	0.235	0.250	5.97	6.35
B	0.250	0.265	6.35	6.73
C	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
E	0.033	0.040	0.84	1.01
F	0.037	0.047	0.94	1.19
G	0.090 BSC		2.29 BSC	
H	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
K	0.350	0.380	8.89	9.65
R	0.175	0.215	4.45	5.46
S	0.050	0.090	1.27	2.28
V	0.030	0.050	0.77	1.27

- STYLE 1:
PIN 1. BASE
2. COLLECTOR
3. EMITTER
4. COLLECTOR

ON Semiconductor and  are registered trademarks of Semiconductor Components Industries, LLC (SCILLC). SCILLC reserves the right to make changes without further notice to any products herein. SCILLC makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does SCILLC assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. "Typical" parameters which may be provided in SCILLC data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. SCILLC does not convey any license under its patent rights nor the rights of others. SCILLC products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other applications intended to support or sustain life, or for any other application in which the failure of the SCILLC product could create a situation where personal injury or death may occur. Should Buyer purchase or use SCILLC products for any such unintended or unauthorized application, Buyer shall indemnify and hold SCILLC and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that SCILLC was negligent regarding the design or manufacture of the part. SCILLC is an Equal Opportunity/Affirmative Action Employer.

PUBLICATION ORDERING INFORMATION

Literature Fulfillment:
Literature Distribution Center for ON Semiconductor
P.O. Box 5163, Denver, Colorado 80217 USA
Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada
Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada
Email: ONlit@hibbertco.com

N. American Technical Support: 800-282-9855 Toll Free USA/Canada

JAPAN: ON Semiconductor, Japan Customer Focus Center
4-32-1 Nishi-Gotanda, Shinagawa-ku, Tokyo, Japan 141-0031
Phone: 81-3-5740-2700
Email: r14525@onsemi.com

ON Semiconductor Website: <http://onsemi.com>

For additional information, please contact your local Sales Representative.